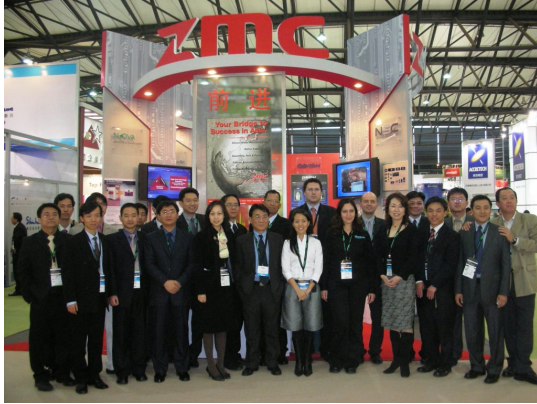


Semicon China 2007

At Semicon China 2007, held from 21 – 23 March in Shanghai, a total of 27,013 visitors were recorded with 997 exhibiting companies.



ZMC's booth was strategically located at the crossroads of the show hall's main aisles which provided a lot of visibility for ZMC and its co-exhibiting principals. Covering 54 sqm of raw space, ZMC's booth co-exhibited with the following principals together with their latest products.

- AAT – Handler
- Gavish – Sapphire parts
- ISIS – Contactless Wafer Inspection System
- LTX – SOC Tester
- Nova – Integrated Thickness Monitoring System
- NSC – Plastic Decapsulation System, Curve Tracer, RIE System
- Soft Test Asia – Test Technology Courses
- SUSS MicroTec – Manual and Semi-auto Probing System
- Visdynamics – Tape and Reel